

3.40J / 22.71J
Modern Physical Metallurgy
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Lecture 5: Introduction to 2D defects

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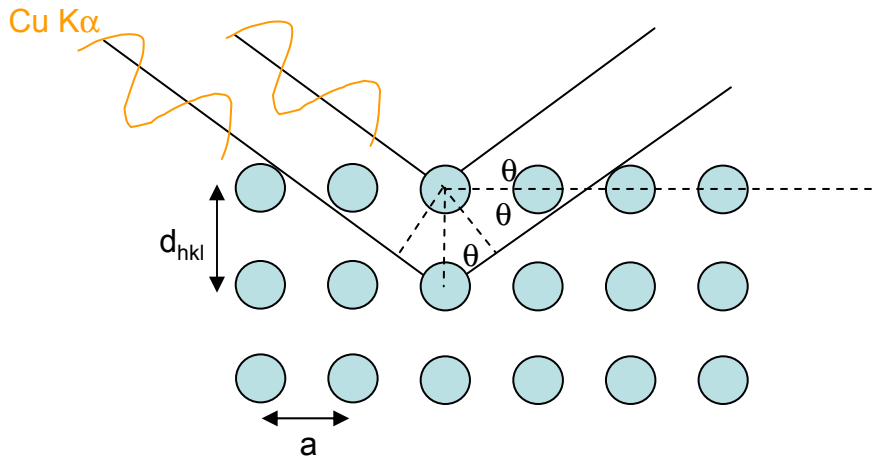
Clarification from PS1:

First-order diffraction:

$$n = 1$$

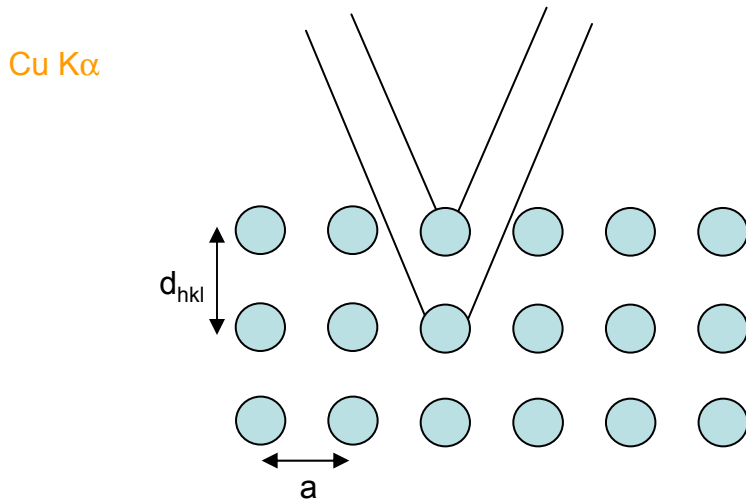
Second-order diffraction:

$$n = 2$$



$$n\lambda = 2d_{hkl}\sin(\theta) \rightarrow$$

Can be several θ that satisfy this condition for the same set of planes!



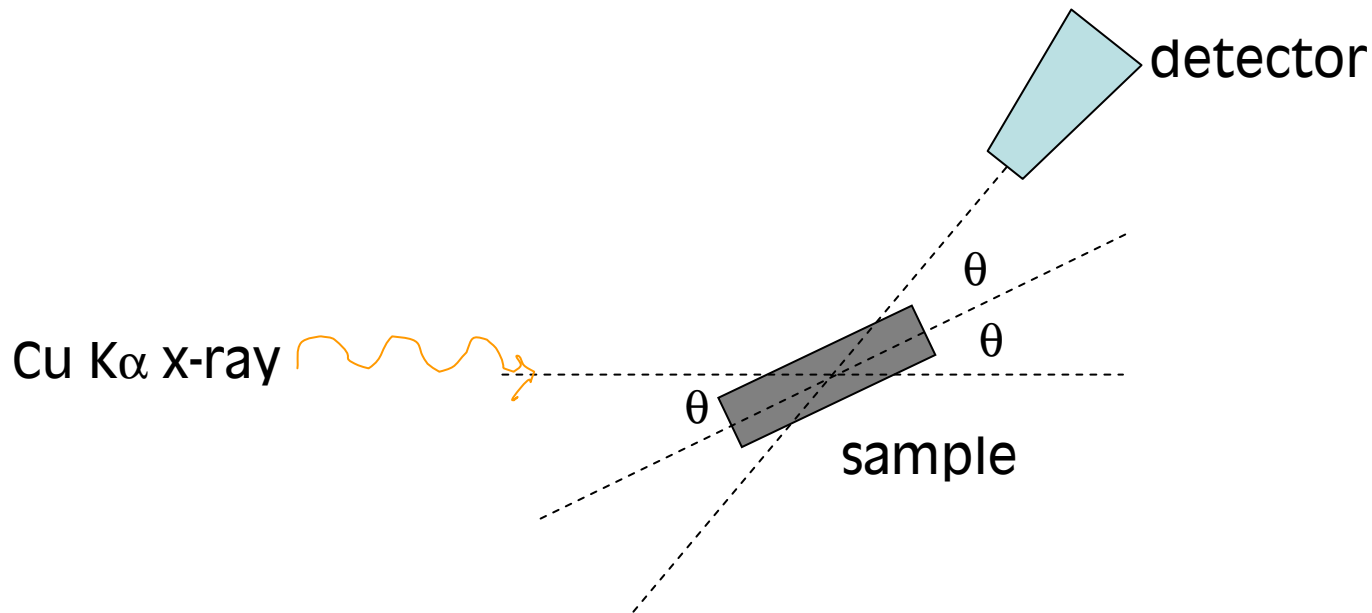
Clarification from PS1:

First-order diffraction: $n = 1$
Second-order diffraction: $n = 2$

Q: What order is contained in an XRD spectrum?

A: $n = 1$ for all peaks

Reason: X-Ray Diffractometer rotates the crystal and the detector, with detector positioned 2θ away and moving twice as fast. This means that the detector only picks up the lower incident angle (ie, $n = 1$) reflections.



Types of 2D defects, or dislocations in perfect crystalline order:

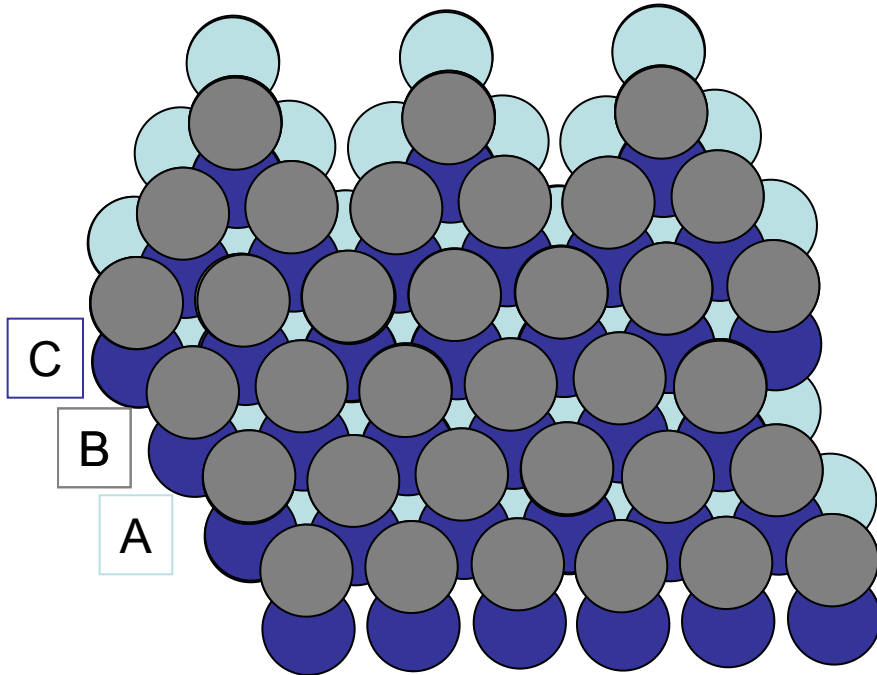
- Stacking faults
- Twins
- Edge dislocations
- Screw dislocations

Continued on next page.

Stacking fault

Stack close-packed planes in wrong sequence
Creates extra or missing plane inside the crystal

FCC stacking: ABCABCABC



Edge dislocation

Definitions:

- (1) Extra half-plane of atoms inserted in otherwise perfect crystal
- (2) Boundary between sheared and unsheared regions on slip plane